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# 150-mW STEREO AUDIO POWER AMPLIFIER 

## FEATURES

- 150 mW Stereo Output
- PC Power Supply Compatible
- Fully Specified for 3.3 V and 5 V Operation
- Operation to 2.5 V
- Pop Reduction Circuitry
- Internal Mid-Rail Generation
- Thermal and Short-Circuit Protection
- Surface-Mount Packaging
- PowerPAD ${ }^{\text {TM }}$ MSOP
- Pin Compatible With LM4881


## DESCRIPTION

The TPA102 is a stereo audio power amplifier packaged in an 8-pin PowerPADTM MSOP package capable of delivering 150 mW of continuous RMS power per channel into $8-\Omega$ loads. Amplifier gain is externally configured by means of two resistors per input channel and does not require external compensation for settings of 1 to 10 .

THD +N when driving an $8-\Omega$ load from 5 V is $0.1 \%$ at 1 kHz , and less than $2 \%$ across the audio band of 20 Hz to 20 kHz . For $32-\Omega$ loads, the THD+N is reduced to less than $0.06 \%$ at 1 kHz , and is less than $1 \%$ across the audio band of 20 Hz to 20 kHz . For $10-\mathrm{k} \Omega$ loads, the $\mathrm{THD}+\mathrm{N}$ performance is $0.01 \%$ at 1 kHz , and less than $0.02 \%$ across the audio band of 20 Hz to 20 kHz .

TYPICAL APPLICATION CIRCUIT


Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.
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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

AVAILABLE OPTIONS

| $\mathbf{T}_{\mathbf{A}}$ | PACKAGED DEVICE | MSOP Symbolization |
| :---: | :---: | :---: |
|  | MSOP(1) |  |
| $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ | TPA102DGN | TI AAC |

(1) The DGN package is available inleft-ended tape and reel only (e.g., TPA102DGNR).

Terminal Functions

| TERMINAL |  | I/O | DESCRIPTION |
| :---: | :---: | :---: | :---: |
| NAME | No. |  |  |
| BYPASS | 1 | 1 | Tap to voltage divider for internal mid-supply bias supply. Connect to a $0.1 \mu \mathrm{~F}$ to $1 \mu \mathrm{~F}$ low ESR capacitor for best performance. |
| GND | 2 | 1 | GND is the ground connection. |
| IN1- | 8 | 1 | IN1- is the inverting input for channel 1. |
| IN2- | 4 | 1 | IN2- is the inverting input for channel 2. |
| SHUTDOWN | 3 | I | Puts the device in a low quiescent current mode when held high. |
| $\mathrm{V}_{\mathrm{DD}}$ | 6 | 1 | $\mathrm{V}_{\mathrm{DD}}$ is the supply voltage terminal. |
| $\mathrm{V}_{0} 1$ | 7 | 0 | $\mathrm{V}_{0} 1$ is the audio output for channel 1. |
| $\mathrm{V}_{\mathrm{O}} 2$ | 5 | O | $\mathrm{V}_{\mathrm{O}} 2$ is the audio output for channel 2. |
| Thermal Pad |  |  |  |

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted) ${ }^{(1)}$

|  |  | UNIT |
| :--- | :--- | :---: |
| $\mathrm{V}_{\mathrm{DD}}$ | Supply voltage | 6 V |
| $\mathrm{~V}_{\mathrm{I}}$ | Input voltage | -0.3 V to $\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}$ |
|  | Continuous total power dissipation | Internally limited |
| $\mathrm{T}_{\mathrm{J}}$ | Operating junction temperature range | $-40^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage temperature range | $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ |
|  | Lead temperature $1,6 \mathrm{~mm}$ (1/16 inch) from case for 10 seconds | $260^{\circ} \mathrm{C}$ |

(1) Stresses beyond thoselisted under "absolute maximum ratings" may cause permanent damage to thedevice. These are stress ratings only, and functional operation of the deviceat these or any other conditions beyond those indicated under "recommendedoperating conditions" is not implied. Exposure to absolute-maximum-ratedconditions for extended periods may affect devicereliability.

DISSIPATION RATING TABLE

| PACKAGE | $\begin{gathered} \mathrm{T}_{\mathrm{A}} \leq 25^{\circ} \mathrm{C} \\ \text { POWER RATING } \end{gathered}$ | DERATING FACTOR ABOVE TA $=25^{\circ} \mathrm{C}$ | $\mathrm{T}_{\mathrm{A}}=70^{\circ} \mathrm{C}$ <br> POWER RATING | $\mathrm{T}_{\mathrm{A}}=85^{\circ} \mathrm{C}$ <br> POWER RATING |
| :---: | :---: | :---: | :---: | :---: |
| DGN | $2.14 \mathrm{~W}^{(1)}$ | $17.1 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ | 1.37 W | 1.11 W |

(1) See the Texas Instrumentsdocument, PowerPAD Thermally EnhancedPackage Application Report (SLMA002), for more information on thePowerPAD package. The thermal data was measured on a PCB layout based on theinformation in the section entitled TexasInstruments Recommended Board for PowerPAD on page 33 of the beforementioned document.

## RECOMMENDED OPERATING CONDITIONS

|  |  | MIN | MAX |
| :--- | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{DD}}$ | Unply |  |  |
| $\mathrm{T}_{\mathrm{A}}$ | Operating free-air temperature | 2.5 |  |
| $\mathrm{~V}_{\text {IH }}$ | High-level input voltage (SHUTDOWN) | 5.5 | V |
| $\mathrm{~V}_{\text {IL }}$ | Low-level input voltage (SHUTDOWN) | -40 |  |

## DC ELECTRICAL CHARACTERISTICS

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=2.5 \mathrm{~V}$ (unless otherwise noted)

|  | PARAMETER | TEST CONDITIONS | MIN | TYP |
| :--- | :--- | :--- | ---: | ---: |
| $\mathrm{V}_{\mathrm{OO}}$ | Output offset voltage (measured between output and BYPASS terminal) | $\mathrm{A}_{\mathrm{V}}=2 \mathrm{~V} / \mathrm{V}$ | UNIT |  |
| PSRR | Power supply rejection ratio | $\mathrm{V}_{\mathrm{DD}}=3.2 \mathrm{~V}$ to 3.4 V |  | 10 |
| $\mathrm{I}_{\mathrm{DD}}$ | Supply current | SHUTDOWN $=0 \mathrm{~V}$ | mV |  |
| $\mathrm{I}_{\mathrm{DD}(\mathrm{SD})}$ | Supply current in SHUTDOWN mode | SHUTDOWN $=\mathrm{V}_{\mathrm{DD}}$ | 1.5 | 3 |
| $\mathrm{Z}_{\mathrm{I}}$ | Input impedance |  | mA |  |

## AC OPERATING CHARACTERISTICS

$\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{L}}=8 \Omega$

| PARAMETER | TEST CONDITIONS | MIN | TYP |
| :--- | :--- | ---: | :---: |
| $\mathrm{P}_{\mathrm{O}}$ | Output power (each channel) | MHD $\leq 0.1 \%$ | UNIT |
| THD +N | Total harmonic distortion + noise | $\mathrm{P}_{\mathrm{O}}=70 \mathrm{~mW}, 20-20 \mathrm{kHz}$ | $2 \%$ |
| $\mathrm{~B}_{\mathrm{OM}}$ | Maximum output power BW | $\mathrm{G}=10, \mathrm{THD}<5 \%$ | m |
|  | Phase margin | Open loop | 520 |
|  | Supply ripple rejection ratio | $\mathrm{f}=1 \mathrm{kHz}$ | $58^{\circ}$ |
|  | $\mathrm{f}=1 \mathrm{kHz}$ | 68 | kHz |
|  | Channel/channel output separation | $\mathrm{P}_{\mathrm{O}}=100 \mathrm{~mW}$ | 86 |
| SNR | Signal-to-noise ratio |  | 100 |
| $\mathrm{~V}_{\mathrm{n}}$ | Noise output voltage | 9.5 | dB |

(1) Measured at 1 kHz

## DC ELECTRICAL CHARACTERISTICS

at $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{V}_{\mathrm{DD}}=5.5 \mathrm{~V}$ (unless otherwise noted)

| PARAMETER |  | TEST CONDITIONS | MIN TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{OO}}$ | Output offset voltage | $\mathrm{A}_{\mathrm{V}}=2 \mathrm{~V} / \mathrm{V}$ |  | 10 | mV |
| PSRR | Power supply rejection ratio | $\mathrm{V}_{\mathrm{DD}}=4.9 \mathrm{~V}$ to 5.1 V | 76 |  | dB |
| $\mathrm{I}_{\mathrm{DD}}$ | Supply current | SHUTDOWN $=0 \mathrm{~V}$ | 1.5 | 3 | mA |
| $\mathrm{I}_{\text {DD(SD) }}$ | Supply current in SHUTDOWN mode | SHUTDOWN $=\mathrm{V}_{\text {DD }}$ | 60 | 100 | $\mu \mathrm{A}$ |
| $\\|_{1 H} \mid$ | High-level input current (SHUTDOWN) | $\mathrm{V}_{\mathrm{DD}}=5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{DD}}$ |  | 1 | $\mu \mathrm{A}$ |
| \|ILIL | Low-level input current (SHUTDOWN) | $\mathrm{V}_{\mathrm{DD}}=5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{I}}=0 \mathrm{~V}$ |  | 1 | $\mu \mathrm{A}$ |
| $\mathrm{Z}_{1}$ | Input impedance |  | >1 |  | $\mathrm{M} \Omega$ |

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## AC OPERATING CHARACTERISTICS

$\mathrm{V}_{\mathrm{DD}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{L}}=8 \Omega$

| PARAMETER | TEST CONDITIONS | MIN | TYP |
| :--- | :--- | ---: | :---: |
| $\mathrm{P}_{\mathrm{O}}$ | Output power (each channel) | MHD $\leq 0.1 \%$ | UNIT |
| THD +N | Total harmonic distortion + noise | $\mathrm{P}_{\mathrm{O}}=150 \mathrm{~mW}, 20-20 \mathrm{kHz}$ | $2 \%$ |
| $\mathrm{~B}_{\mathrm{OM}}$ | Maximum output power BW | $\mathrm{G}=10, \mathrm{THD}<5 \%$ | m |
|  | Phase margin | Open loop | 520 |
|  | Supply ripple rejection ratio | $\mathrm{f}=1 \mathrm{kHz}$ | $56^{\circ}$ |
|  | $\mathrm{f}=1 \mathrm{kHz}$ | 68 | kHz |
|  | Channel/Channel output separation | $\mathrm{P}_{\mathrm{O}}=150 \mathrm{~mW}$ | 86 |
| SNR | Signal-to-noise ratio |  | 100 |
| $\mathrm{~V}_{\mathrm{n}}$ | Noise output voltage | 9.5 | dB |

(1) Measured at 1 kHz

## AC OPERATING CHARACTERISTICS

$\mathrm{V}_{\mathrm{DD}}=3.3 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{L}}=32 \Omega$

| PARAMETER |  | TEST CONDITIONS | MIN TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{P}_{\mathrm{O}}$ | Output power (each channel) | THD $\leq 0.1 \%$ | $40^{(1)}$ |  | mW |
| THD + N | Total harmonic distortion + noise | $\mathrm{P}_{\mathrm{O}}=30 \mathrm{~mW}, 20-20 \mathrm{kHz}$ | 0.5\% |  |  |
| $\mathrm{B}_{\text {OM }}$ | Maximum output power BW | $A_{V}=10, \mathrm{THD}<2 \%$ | >20 |  | kHz |
|  | Phase margin | Open loop | $58^{\circ}$ |  |  |
|  | Supply ripple rejection ratio | $\mathrm{f}=1 \mathrm{kHz}$ | 68 |  | dB |
|  | Channel/channel output separation | $\mathrm{f}=1 \mathrm{kHz}$ | 97 |  | dB |
| SNR | Signal-to-noise ratio | $\mathrm{P}_{\mathrm{O}}=100 \mathrm{~mW}$ | 100 |  | dB |
| $\mathrm{V}_{\mathrm{n}}$ | Noise output voltage |  | 9.5 |  | $\mu \mathrm{V}$ (rms) |

(1) Measured at 1 kHz

## AC OPERATING CHARACTERISTICS

$V_{D D}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{L}}=32 \Omega$

|  | PARAMETER | TEST CONDITIONS | MIN TYP | MAX | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{P}_{0}$ | Output power (each channel) | THD $\leq 0.1 \%$ | $40^{(1)}$ |  | mW |
| THD+N | Total harmonic distortion + noise | $\mathrm{P}_{\mathrm{O}}=60 \mathrm{~mW}, 20-20 \mathrm{kHz}$ | 0.4\% |  |  |
| $\mathrm{B}_{\mathrm{OM}}$ | Maximum output power BW | $\mathrm{A}_{\mathrm{V}}=10, \mathrm{THD}<2 \%$ | >20 |  | kHz |
|  | Phase margin | Open loop | $56^{\circ}$ |  |  |
|  | Supply ripple rejection ratio | $\mathrm{f}=1 \mathrm{kHz}$ | 68 |  | dB |
|  | Channel/channel output separation | $\mathrm{f}=1 \mathrm{kHz}$ | 97 |  | dB |
| SNR | Signal-to-noise ratio | $\mathrm{P}_{\mathrm{O}}=150 \mathrm{~mW}$ | 100 |  | dB |
| $\mathrm{V}_{\mathrm{n}}$ | Noise output voltage |  | 9.5 |  | $\mu \mathrm{V}$ (rms) |

(1) Measured at 1 kHz

## TYPICAL CHARACTERISTICS

Table of Graphs

|  |  |  | FIGURE |
| :---: | :---: | :---: | :---: |
| THD + N | Total harmonic distortion plus noise | vs Frequency | 1, 2, 4, 5, 7, 8, 10, 11, 13, 14, 16, 17, 34, 36 |
|  |  | vs Power output | 3, 6, 9, 12, 15, 18 |
|  | Power supply rejection ratio | vs Frequency | 19, 20 |
| $\mathrm{V}_{\mathrm{n}}$ | Output noise voltage | vs Frequency | 21, 22 |
|  | Crosstalk | vs Frequency | 23-26, 37, 38 |
|  | Mute attenuation | vs Frequency | 27, 28 |
|  | Open-loop gain | vs Frequency |  |
|  | Phase margin | Frequency | 29, |
|  | Output power | vs Load resistance | 31,32 |
| $\mathrm{I}_{\mathrm{DD}}$ | Supply current | vs Supply voltage | 33 |
| SNR | Signal-to-noise ratio | vs Voltage gain | 35 |
|  | Closed-loop gain | vs Frequency | 39-44 |
|  | Phase |  |  |
|  | Power dissipation | vs Output power | 45, 46 |



Figure 1.

TOTAL HARMONIC DISTORTION + NOISE vS FREQUENCY


Figure 4.
TOTAL HARMONIC DISTORTION + NOISE OUTPUT POWER


Figure 6.


Figure 7.


Figure 9.

Figure 8.
TOTAL HARMONIC DISTORTION + NOISE FREQUENCY


Figure 10.


Figure 11.


Figure 13.

TOTAL HARMONIC DISTORTION + NOISE OUTPUT POWER


Figure 12.
TOTAL HARMONIC DISTORTION + NOISE FREQUENCY


Figure 14.


Figure 15.
TOTAL HARMONIC DISTORTION + NOISE
FREQUENCY


Figure 17.

Figure 16.
TOTAL HARMONIC DISTORTION + NOISE POWER OUTPUT


Figure 18.


Figure 19.


Figure 21.


Figure 20.


Figure 22.
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Figure 23.
CROSSTALK
vs
FREQUENCY


Figure 25.


Figure 24.
CROSSTALK
FREQUENCY


Figure 26.


Figure 27.


Figure 29.

MUTE ATTENUATION
FREQUENCY


Figure 28.


Figure 30.


Figure 31.


Figure 33.


Figure 32.
TOTAL HARMONIC DISTORTION + NOISE FREQUENCY


Figure 34.


Figure 35.


Figure 37.

TOTAL HARMONIC DISTORTION + NOISE VS FREQUENCY


Figure 36.
CROSSTALK
FREQUENCY


Figure 38.


Figure 39.


Figure 41.

CLOSED-LOOP GAIN AND PHASE
FREQUENCY


Figure 40.

Phase

CLOSED-LOOP GAIN AND PHASE
vS
FREQUENCY


Closed-Loop Gain - dB


Figure 42.


Figure 43.


Figure 45.

CLOSED-LOOP GAIN AND PHASE
FREQUENCY


Figure 44.
POWER DISSIPATION/AMPLIFIER OUTPUT POWER


Figure 46.

## APPLICATION INFORMATION

## GAIN SETTING RESISTORS, $\mathbf{R}_{\mathrm{f}}$ and $\mathbf{R}_{\mathrm{i}}$

The gain for the TPA102 is set by resistors $R_{f}$ and $R_{i}$ according to Equation 1.

$$
\begin{equation*}
\text { Gain }=-\left(\frac{R_{f}}{R_{i}}\right) \tag{1}
\end{equation*}
$$

Given that the TPA102 is a MOS amplifier, the input impedance is very high. Consequently input leakage currents are not generally a concern. However, noise in the circuit increases as the value of $\mathrm{R}_{\mathrm{f}}$ increases. In addition, a certain range of $R_{f}$ values is required for proper start-up operation of the amplifier. Considering these factors, it is recommended that the effective impedance seen by the inverting node of the amplifier be set between $5 \mathrm{k} \Omega$ and $20 \mathrm{k} \Omega$. The effective impedance is calculated using Equation 2.

$$
\begin{equation*}
\text { Effective Impedance }=\frac{R_{f} R_{i}}{R_{f}+R_{i}} \tag{2}
\end{equation*}
$$

For example, if the input resistance is $20 \mathrm{k} \Omega$ and the feedback resistor is $20 \mathrm{k} \Omega$, the gain of the amplifier is -1 , and the effective impedance at the inverting terminal is $10 \mathrm{k} \Omega$, a value within the recommended range.
For high performance applications, metal-film resistors are recommended because they tend to have lower noise levels than carbon resistors. For values of $R_{f}$ above $50 \mathrm{k} \Omega$, the amplifier tends to become unstable due to a pole formed from $\mathrm{R}_{\mathrm{f}}$ and the inherent input capacitance of the MOS input structure. For this reason, a small compensation capacitor of approximately 5 pF should be placed in parallel with $\mathrm{R}_{\mathrm{f}}$. This, in effect, creates a low-pass filter network with the cutoff frequency defined by Equation 3.

$$
\begin{equation*}
\mathrm{f}_{\mathrm{C}(\text { lowpass })}=\frac{1}{2 \pi R_{\mathrm{f}} \mathrm{C}_{\mathrm{F}}} \tag{3}
\end{equation*}
$$

For example, if $R_{f}$ is $100 \mathrm{k} \Omega$ and $C_{F}$ is 5 pF then $\mathrm{f}_{\text {c(lowpass) }}$ is 318 kHz , which is well outside the audio range.

## INPUT CAPACITOR, $\mathrm{C}_{\mathrm{i}}$

In the typical application, an input capacitor, $\mathrm{C}_{\mathrm{i}}$, is required to allow the amplifier to bias the input signal to the proper dc level for optimum operation. In this case, $C_{i}$ and $R_{i}$ form a high-pass filter with the corner frequency determined in Equation 4.

$$
\begin{equation*}
\mathrm{f}_{\mathrm{c}(\text { highpass })}=\frac{1}{2 \pi \mathrm{R}_{\mathrm{i}} \mathrm{C}_{\mathrm{i}}} \tag{4}
\end{equation*}
$$

The value of $\mathrm{C}_{\mathrm{i}}$ directly affects the bass (low frequency) performance of the circuit. Consider the example where $R_{i}$ is $20 \mathrm{k} \Omega$ and the specification calls for a flat bass response down to 20 Hz . Equation 4 is reconfigured as Equation 5.

$$
\begin{equation*}
\mathrm{C}_{\mathrm{i}}=\frac{1}{2 \pi \mathrm{R}_{\mathrm{i}} \mathrm{f}_{\mathrm{c}}(\text { highpass })} \tag{5}
\end{equation*}
$$

In this example, $\mathrm{C}_{\mathrm{i}}$ is $0.40 \mu \mathrm{~F}$, so one would likely choose a value in the range of $0.47 \mu \mathrm{~F}$ to $1 \mu \mathrm{~F}$. A further consideration for this capacitor is the leakage path from the input source through the input network formed by $R_{i}, C_{i}$, and the feedback resistor ( $R_{f}$ ) to the load. This leakage current creates a dc offset voltage at the input to the amplifier that reduces useful headroom, especially in high-gain applications (gain $>10$ ). For this reason a low-leakage tantalum or ceramic capacitor is the best choice. When polarized capacitors are used, connect the positive side of the capacitor to the amplifier input in most applications. The dc level there is held at $\mathrm{V}_{\mathrm{DD}} / 2$-likely higher than the source dc level. It is important to confirm the capacitor polarity in the application.

## POWER SUPPLY DECOUPLING, $\mathrm{C}_{(\mathrm{s})}$

The TPA102 is a high-performance CMOS audio amplifier that requires adequate power-supply decoupling to minimize the output total harmonic distortion (THD). Power-supply decoupling also prevents oscillations when long lead lengths are used between the amplifier and the speaker. The optimum decoupling is achieved by using two capacitors of different types that target different types of noise on the power supply leads. For higher frequency transients, spikes, or digital hash on the line, a good low equival-ent-series-resistance (ESR) ceramic capacitor, typically $0.1 \mu \mathrm{~F}$, placed as close as possible to the device $V_{D D}$ lead, works best. For filtering lower-frequency noise signals, a larger aluminum electrolytic capacitor of $10 \mu \mathrm{~F}$ or greater placed near the power amplifier is recommended.

Table 1. Common Load Impedances vs LowFrequency Output Characteristics in SE Mode

| $\mathbf{R}_{\mathbf{L}}$ | $\mathbf{C}_{(\mathbf{C})}$ | LOWEST FREQUENCY |
| :---: | :---: | :---: |
| $32 \Omega$ | $68 \mu \mathrm{~F}$ | 73 Hz |
| $10,000 \Omega$ | $68 \mu \mathrm{~F}$ | 0.23 Hz |
| $47,000 \Omega$ | $68 \mu \mathrm{~F}$ | 0.05 Hz |

As Table 1 indicates, headphone response is adequate, and drive into line level inputs (a home stereo for example) is very good.
The output coupling capacitor required in single-supply SE mode also places additional constraints on the selection of other components in the amplifier circuit. With the rules described earlier still valid, add the following relationship:

$$
\begin{equation*}
\frac{1}{\left(\mathrm{C}_{(\mathrm{B})} \times 230 \mathrm{k} \Omega\right)} \leq \frac{1}{\left(\mathrm{C}_{\mathrm{i}} \mathrm{R}_{\mathrm{i}}\right)} \ll \frac{1}{\mathrm{R}_{\mathrm{L}} \mathrm{C}_{(\mathrm{C})}} \tag{8}
\end{equation*}
$$

## USING LOW-ESR CAPACITORS

Low-ESR capacitors are recommended throughout this application. A real capacitor can be modeled simply as a resistor in series with an ideal capacitor. The voltage drop across this resistor minimizes the beneficial effects of the capacitor in the circuit. The lower the equivalent value of this resistance, the more the real capacitor behaves like an ideal capacitor.

## 5-V VERSUS 3.3-V OPERATION

The TPA102 was designed for operation over a supply range of 2.5 V to 5.5 V . This data sheet provides full specifications for $5-\mathrm{V}$ and $3.3-\mathrm{V}$ operation, since these are considered to be the two most common supply voltages. There are no special considerations for $3.3-\mathrm{V}$ versus $5-\mathrm{V}$ operation as far as supply bypassing, gain setting, or stability. The most important consideration is that of output power. Each amplifier in theTPA102 can produce a maximum voltage swing of $\mathrm{V}_{\mathrm{DD}}-1 \mathrm{~V}$. This means, for $3.3-\mathrm{V}$ operation, clipping starts to occur when $\mathrm{V}_{\mathrm{O}(\mathrm{PP})}=2.3 \mathrm{~V}$ as opposed when $\mathrm{V}_{\mathrm{O}(\mathrm{PP)}}=4 \mathrm{~V}$ while operating at 5 V . The reduced voltage swing subsequently reduces maximum output power into the load before distortion becomes significant.

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead finish/ Ball material <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TPA102DGN | ACTIVE | HVSSOP | DGN | 8 | 80 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM |  | AAC | Samples |
| TPA102DGNR | ACTIVE | HVSSOP | DGN | 8 | 2500 | RoHS \& Green | NIPDAU | Level-1-260C-UNLIM |  | AAC | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION


*All dimensions are nominal

| Device | Package <br> Type | Package <br> Drawing | Pins | SPQ | Reel <br> Diameter <br> $(\mathbf{m m})$ | Reel <br> Width <br> $\mathbf{W 1}(\mathbf{m m})$ | A0 <br> $(\mathbf{m m})$ | B0 <br> $(\mathbf{m m})$ | K0 <br> $(\mathbf{m m})$ | P1 <br> $(\mathbf{m m})$ | W <br> $(\mathbf{m m})$ | Pin1 <br> Quadrant |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TPA102DGNR | HVSSOP | DGN | 8 | 2500 | 330.0 | 12.4 | 5.3 | 3.4 | 1.4 | 8.0 | 12.0 | Q1 |


*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| TPA102DGNR | HVSSOP | DGN | 8 | 2500 | 358.0 | 335.0 | 35.0 |

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



NOTES:
PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.


LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X


NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9 . Size of metal pad may vary due to creepage requirement.


SOLDER PASTE EXAMPLE
EXPOSED PAD 9:
100\% PRINTED SOLDER COVERAGE BY AREA
SCALE: 15X

| STENCIL <br> THICKNESS | SOLDER STENCIL <br> OPENING |
| :---: | :---: |
| 0.1 | $1.76 \times 2.11$ |
| 0.125 | $1.57 \times 1.89($ SHOWN $)$ |
| 0.15 | $1.43 \times 1.73$ |
| 0.175 | $1.33 \times 1.60$ |

NOTES: (continued)
10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
11. Board assembly site may have different recommendations for stencil design.

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